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QUESTION 1

During the Process Cycle Test, the coverage type paths is used. In which way can coverage be varied here?

- A. by using boundary values
- B. by using a higher or lower test depth level
- C. by taking equivalence classes into consideration

Correct Answer: B

QUESTION 2

For the creation of the central starting point there are several techniques. In the given situation it is necessary that consistency between the data entered is guaranteed. Which of the techniques below is preferable if only one technique may be used?

- A. use of production data
- B. entering through separate front-end software
- C. entering through regular system functions

Correct Answer: C

QUESTION 3

The test infrastructure consists of facilities and resources required to conduct testing effectively. Which facility does not belong to the testing infrastructure?

- A. test environments
- B. test design techniques
- C. test tools
- D. workplaces

Correct Answer: B

QUESTION 4

What constitutes a good test environment?

- A. it is possible to adequately determine to what extent the test object meets the requirements
- B. it has been configured and tested by qualified personnel
- C. it meets both of the requirements listed above
- D. it is as similar to the production environment as possible and the test data is consistent

Correct Answer: A

QUESTION 5

Which defects can be detected more effectively with development tests than with system and/or acceptance tests?

- A. defects related to effectivity
- B. defects related to the database and/or the operating system
- C. defects related to the functional specifications
- D. defects related to performance

Correct Answer: B

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